

Dual Channel, Ultra-Low Resistance Load Switch

Check for Samples: TPS22966

FEATURES

- Integrated dual channel load switch
- Input voltage range: 0.8V to 5.5V
- Ultra low R_{ON} resistance
 - $R_{ON} = 18m\Omega$ at $V_{IN} = 5V$ ($V_{BIAS} = 5V$)
 - $R_{ON} = 18mΩ$ at $V_{IN} = 3.6V$ ($V_{BIAS} = 5V$)
 - $R_{ON} = 18mΩ$ at $V_{IN} = 1.8V$ ($V_{BIAS} = 5V$)
- 6A maximum continuous switch current per channel
- Low quiescent current
 - 80µA (both channels)
 - 60µA (single channel)
- Low control input threshold enables use of 1.2-V/1.8-V/2.5-V/3.3-V logic
- · Configurable rise time
- Quick Output Discharge (QOD)
- SON 14-pin package with Thermal Pad
- ESD performance tested per JESD 22
 - 2KV HBM and 1KV CDM

APPLICATIONS

- Ultrabook™
- Notebooks/Netbooks
- Tablet PC
- Consumer electronics
- Set-top boxes/Residental gateways
- Telecom systems
- Solid State Drives (SSD)

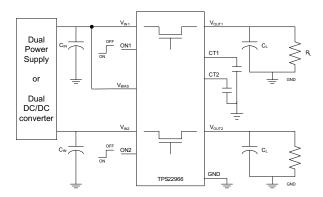


Figure 1. Typical Application

DESCRIPTION

The TPS22966 is a small, ultra-low RON, dual channel load switch with controlled turn on. The device contains two N-channel MOSFETs that can operate over an input voltage range of 0.8V to 5.5V and can support a maximum continuous current of 6A per channel. Each switch is independently controlled by an on/off input (ON1 and ON2), which is capable of interfacing directly with low-voltage control signals. In TPS22966, a 220- Ω on-chip load resistor is added for quick output discharge when switch is turned off.

The TPS22966 is available in a small, space-saving 2mm x 3mm 14-SON package (DPU) with integrated thermal pad allowing for high power dissipation. The device is characterized for operation over the free-air temperature range of -40°C to 85°C.

Table 1. Feature List

R _{ON} TYPICAL at 3.6 V (V _{BIAS} = 5V)	18 mΩ
RISE TIME ⁽¹⁾	Adjustable
QUICK OUTPUT DISCHARGE ⁽²⁾	Yes
MAXIMUM OUTPUT CURRENT (per channel)	6 A
GPIO ENABLE	Active High
OPERATING TEMP	-40°C to 85°C

- (1) See Application Information section for CT value vs. rise time.
- (2) This feature discharges output of the switch to GND through a 220- $\!\Omega$ resistor, preventing the output from floating.

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ORDERING INFORMATION

T _A	PACKAGE		ORDERABLE PART NO.	TOP-SIDE MARKING/STATUS
-40°C to 85°C	DPU	Tape and reel 3000 units	TPS22966DPUR	RB966
-40°C to 85°C	DPU	Tape and reel 250 units	TPS22966DPUT	RB966

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)(1)(2)

			VALUE	UNIT ⁽²⁾
$V_{IN1,2}$	Input voltage range		-0.3 to 6	V
$V_{OUT1,2}$	Output voltage range		-0.3 to 6	V
$V_{ON1,2}$	Input voltage range		-0.3 to 6	V
I _{MAX}	Maximum continuous switch	current	6	Α
I _{PLS}	Maximum pulsed switch cur	rent, pulse <300 µs, 2% duty cycle	8	Α
T _A	Operating free-air temperatu	ure range ⁽³⁾	-40 to 85	°C
TJ	Maximum junction temperat	ure	125	°C
T _{STG}	Storage temperature range		-65 to 150	°C
T _{LEAD}	Maximum lead temperature (10-s soldering time)		300	°C
ECD.	Electrostatic discharge	Human-Body Model (HBM)	2000	
ESD	protection	Charged-Device Model (CDM)	1000	V

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute—maximum—rated conditions for extended periods may affect device reliability.

(2) All voltage values are with respect to network ground terminal.

THERMAL INFORMATION

	THERMAL METRIC ⁽¹⁾	TPS22966	LINUTO
	THERMAL METRIC**	DPU (14 PINS)	UNITS
θ_{JA}	Junction-to-ambient thermal resistance	52.3	
θ_{JCtop}	Junction-to-case (top) thermal resistance	45.9	
θ_{JB}	Junction-to-board thermal resistance	11.5	°C/W
ΨЈТ	Junction-to-top characterization parameter	0.8	C/VV
ΨЈВ	Junction-to-board characterization parameter	11.4	
θ_{JCbot}	Junction-to-case (bottom) thermal resistance	6.9	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

⁽³⁾ In applications where high power dissipation and/or poor package thermal resistance is present, the maximum ambient temperature may have to be derated. Maximum ambient temperature [T_{A(max)}] is dependent on the maximum operating junction temperature [T_{J(max)}], the maximum power dissipation of the device in the application [P_{D(max)}], and the junction-to-ambient thermal resistance of the part/package in the application (θ_{JA}), as given by the following equation: TA_(max) = T_{J(max)} – (θ_{JA} × P_{D(max)})



RECOMMENDED OPERATING CONDITIONS

				MIN	MAX	UNIT
V _{IN1,2}	Input voltage range			0.8	V_{BIAS}	V
V _{BIAS}	Bias voltage range			2.5	5.5	V
V _{ON1,2}	ON voltage range			0	V_{IN}	V
V _{OUT1,2}	Output voltage range				V_{IN}	V
V_{IH}	High-level input voltage, ON	V _{BIAS} = 2.5 V to 5.5 V		1.2	5.5	V
V_{IL}	Low-level input voltage, ON	V _{BIAS} = 2.5 V to 5.5 V		0	0.5	V
C _{IN1,2}	Input capacitor	•		1 ⁽¹⁾		μF

⁽¹⁾ Refer to Application Information section.

ELECTRICAL CHARACTERISTICS

Unless otherwise note the specification in the following table applies over the operating ambient temperature $-40^{\circ}\text{C} \le T_{A} \le 85^{\circ}\text{C}$ (full) and $V_{\text{RIAS}} = 5.0 \text{ V}$. Typical values are for $T_{A} = 25^{\circ}\text{C}$. (unless otherwise noted)

	PARAMETER	TEST CON	DITIONS	TA	MIN TYP	MAX	UNIT
POWER SUF	PPLIES AND CURRENTS						
I _{IN(VBIAS-ON)}	V _{BIAS} quiescent current (both channels)	$I_{OUT1} = I_{OUT2} = 0,$ $V_{IN1,2} = V_{ON1,2} = V_{BIAS} = 0$	= 5.0 V	Full	80	120	μΑ
I _{IN(VBIAS-ON)}	V _{BIAS} quiescent current (single channel)	$I_{OUT1} = I_{OUT2} = 0, V_{ON2}$ $V_{IN1,2} = V_{ON1} = V_{BIAS} =$		Full	60		μΑ
I _{IN(VBIAS-OFF)}	V _{BIAS} shutdown current	V _{ON1,2} = GND, V _{OUT1,2} =	= 0 V	Full		2	μΑ
			V _{IN1,2} = 5.0 V		2.1	8	
	V _{IN1,2} off-state supply current (per	$V_{ON1,2} = GND$,	$V_{IN1,2} = 3.3 \text{ V}$	Full	0.3	3	
I _{IN(VIN-OFF)}	channel)	$V_{OUT1,2} = 0 V$	$V_{IN1,2} = 1.8 \text{ V}$	Full	0.07	2	μA
			$V_{IN1,2} = 0.8 V$		0.04	1	
I _{ON}	ON pin input leakage current	V _{ON} = 5.5 V		Full		1	μΑ
RESISTANC	E CHARACTERISTICS						
			V _{IN} = 5.0 V	25°C	18	25	mΩ - mΩ - mΩ
			V _{IN} = 5.0 V	Full		27	
			V _{IN} = 3.3 V	25°C	18	25	
			V _{IN} = 3.3 V	Full		27	
			\/ _ 1 9 \/	25°C	18	25	
D	ON-state resistance	$I_{OUT} = -200 \text{ mA},$	$V_{IN} = 1.8 \text{ V}$	Full		27	
R _{ON}	ON-state resistance	$V_{BIAS} = 5.0 V$	\/ 4 E \/	25°C	18	25	mΩ
			$V_{IN} = 1.5 \text{ V}$	Full		27	
			V 42V	25°C	18	25	
			$V_{IN} = 1.2 \text{ V}$	Full		27	mΩ
			V 0.9.V	25°C	18	25	~ 0
			$V_{IN} = 0.8 V$	Full		27	mΩ
R _{PD}	Output pulldown resistance	$V_{IN} = 5.0 \text{ V}, V_{ON} = 0 \text{V}, I$	_{OUT} = 15 mA	Full	220	300	Ω

Product Folder Link(s): TPS22966



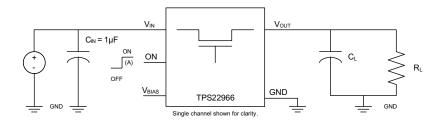
ELECTRICAL CHARACTERISTICS

Unless otherwise noted, the specification in the following table applies over the operating ambient temp $-40^{\circ}\text{C} \le T_{A} \le 85^{\circ}\text{C}$ (full) and $V_{BIAS} = 2.5 \text{ V}$. Typical values are for $T_{A} = 25^{\circ}\text{C}$ unless otherwise noted.

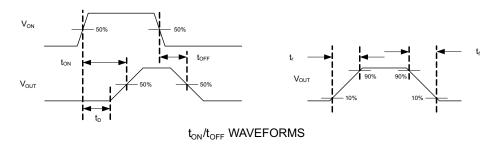
	PARAMETER	TEST CON	TEST CONDITIONS			MAX	UNIT
POWER SUF	PPLIES AND CURRENTS	,					
I _{IN(VBIAS-ON)}	V _{BIAS} quiescent current (both channels)	$I_{OUT1} = I_{OUT2} = 0,$ $V_{IN1,2} = V_{ON1,2} = V_{BIAS}$	= 2.5 V	Full	25	37	μΑ
I _{IN(VBIAS-ON)}	V _{BIAS} quiescent current (single channel)	$I_{OUT1} = I_{OUT2} = 0, V_{ON2}$ $V_{IN1,2} = V_{ON1} = V_{BIAS} = 0$		Full			μΑ
I _{IN(VBIAS-OFF)}	V _{BIAS} shutdown current	$V_{ON1,2} = GND, V_{OUT1,2}$	= 0 V	Full		2	μΑ
			$V_{IN1,2} = 2.5 \text{ V}$		0.13	3	
L	V _{IN1,2} off-state supply current (per	$V_{ON1,2} = GND$,	$V_{IN1,2} = 1.8 \text{ V}$	Full	0.07	2	μΑ
I _{IN(VIN-OFF)}	channel)	$V_{OUT1,2} = 0 V$	$V_{IN1,2} = 1.2 \text{ V}$	Full	0.05	2	μΛ
			$V_{IN1,2} = 0.8 \text{ V}$		0.04	1	
I _{ON}	ON pin input leakage current	$V_{ON} = 5.5 \text{ V}$		Full		1	μΑ
RESISTANC	E CHARACTERISTICS						
			V _{IN} = 2.5 V	25°C	22	28	mΩ
			V _{IN} = 2.5 V	Full		30	11122
			V _{IN} = 1.8 V	25°C	21	28	mΩ
			V _{IN} = 1.0 V	Full		30	11122
D	ON-state resistance	$I_{OUT} = -200 \text{ mA},$	V _{IN} = 1.5 V	25°C	20	27	mΩ
R _{ON}	ON-State resistance	$V_{BIAS} = 2.5 V$	V _{IN} = 1.5 V	Full		29	11122
			V _{IN} = 1.2 V	25°C	20	27	0
			V _{IN} = 1.2 V	Full		29	mΩ
			V = 0.8 V	25°C	19	27	mC
			$V_{IN} = 0.8 V$	Full		29	mΩ
R _{PD}	Output pulldown resistance	$V_{IN} = 2.5 \text{ V}, V_{ON} = 0 \text{V},$	I _{OUT} = 1 mA	Full	260	300	Ω



SWITCHING CHARACTERISTIC MEASUREMENT INFORMATION



TEST CIRCUIT



(A) Rise and fall times of the control signal is 100ns.

Figure 2. Test Circuit and $t_{\text{ON}}/t_{\text{OFF}}$ Waveforms

SWITCHING CHARACTERISTICS

	PARAMETER	TEST CONDITION	MIN TYP MAX	UNIT
V _{IN} = V	/ _{ON} = V _{BIAS} = 5 V, T _A = 25	°C (unless otherwise noted)		•
t _{ON}	Turn-on time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	1210	
t _{OFF}	Turn-off time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	6	
t _R	V _{OUT} rise time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	1370	μs
t _F	V _{OUT} fall time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	2	
t _D	ON delay time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	460	
$V_{IN} = 0$	0.8 V, V _{ON} = V _{BIAS} = 5V, T _A	_A = 25°C (unless otherwise noted)		
t _{ON}	Turn-on time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	550	
t _{OFF}	Turn-off time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	170	
t _R	V _{OUT} rise time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	325	μs
t _F	V _{OUT} fall time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	16	
t_D	ON delay time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	400	
V _{IN} = 2	$2.5V, V_{ON} = 5 V, V_{BIAS} = 2.$.5V, T _A = 25°C (unless otherwise noted)		
t _{ON}	Turn-on time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	2050	
t _{OFF}	Turn-off time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	5	
t_R	V _{OUT} rise time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	2275	μs
t _F	V _{OUT} fall time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	2.5	
t_D	ON delay time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	990	
$V_{IN} = 0$	0.8 V, V _{ON} = 5 V, V _{BIAS} = 2	2.5 V, T _A = 25°C (unless otherwise noted)	•	•
t _{ON}	Turn-on time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	1300	
t _{OFF}	Turn-off time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	130	
t_R	V _{OUT} rise time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	875	μs
t_{F}	V _{OUT} fall time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	16	
t_D	ON delay time	$R_L = 10-\Omega$, $C_L = 0.1 \mu F$, $C_T = 1000 pF$	870	

Product Folder Link(s): TPS22966



FUNCTIONAL BLOCK DIAGRAM

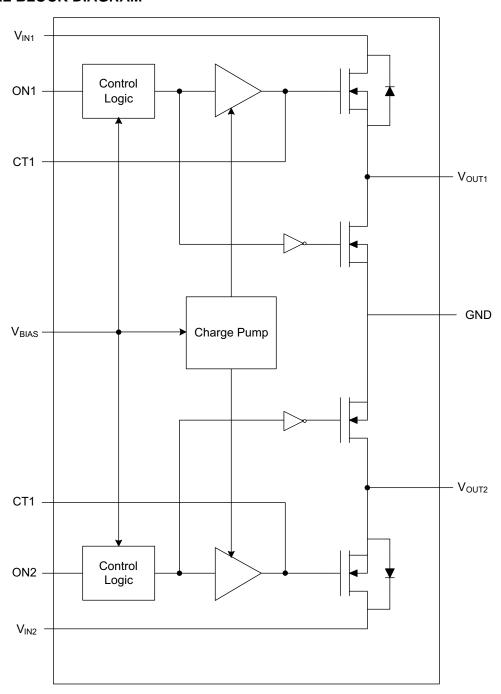
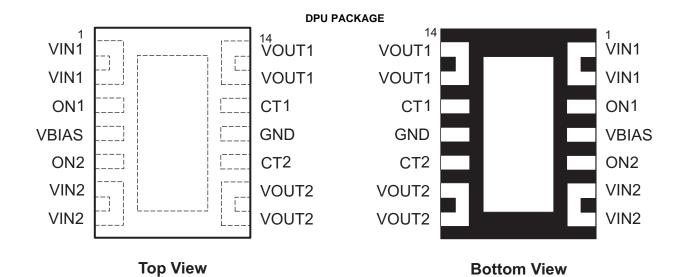


Figure 3. Functional Block Diagram

Table 2. FUNCTIONAL TABLE

ONx	VINx to VOUTx	VOUTx to GND
L	Off	On
Н	On	Off





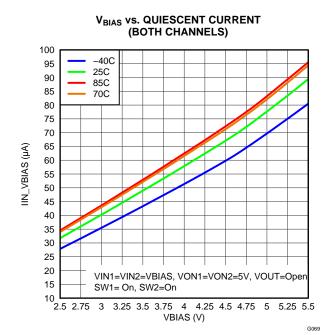
PIN TABLE

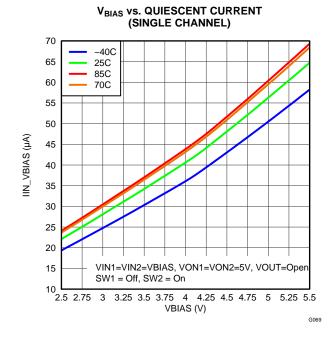
TPS22966	DIN 11445		PERCENTION			
DPU	PIN NAME I/O		DESCRIPTION			
1	VIN1	I	Switch #1 input. Bypass this input with a ceramic capacitor to GND. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8V to V_{BIAS} .			
2	VIN1	I	Switch #1 input. Bypass this input with a ceramic capacitor to GND. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8V to V_{BIAS} .			
3	ON1	I	Active high switch #1 control input. Do not leave floating.			
4	VBIAS	I	Bias voltage. Power supply to the device. Recommended voltage range for this pin is 2.5V to 5.5V. See Application Information section.			
5	ON2	I	Active high switch #2 control input. Do not leave floating.			
6	VIN2	I	Switch #2 input. Bypass this input with a ceramic capacitor to GND. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8V to V_{BIAS} .			
7	VIN2	I	Switch #2 input. Bypass this input with a ceramic capacitor to GND. Recommended voltage range for this pin for optimal R_{ON} performance is 0.8V to V_{BIAS} .			
8	VOUT2	0	Switch #2 output.			
9	VOUT2	0	Switch #2 output.			
10	CT2	0	Switch #2 slew rate control. Can be left floating.			
11	GND	_	Ground			
12	CT1	0	Switch #1 slew rate control. Can be left floating.			
13	VOUT1	0	Switch #2 output.			
14	VOUT1	0	Switch #2 output.			
15	Thermal Pad	0	Thermal pad (exposed center pad) to alleviate thermal stress. Tie to GND. See Application Information for layout guidelines.			

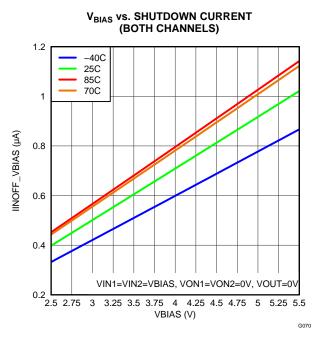
Product Folder Link(s): TPS22966

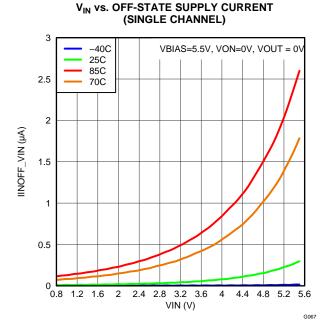


TYPICAL CHARACTERISTICS



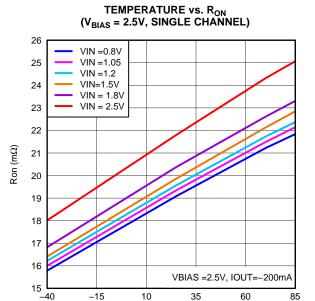




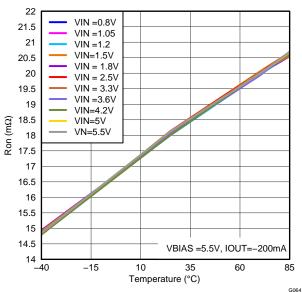


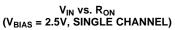


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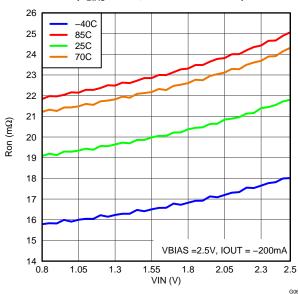




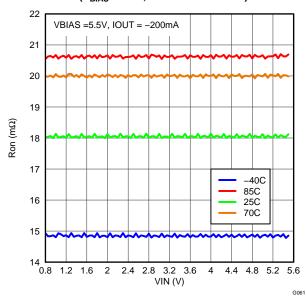




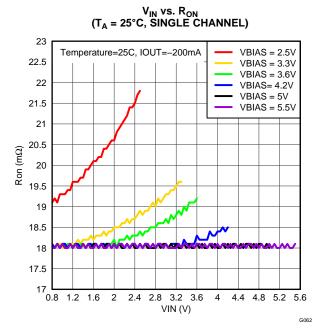
Temperature (°C)

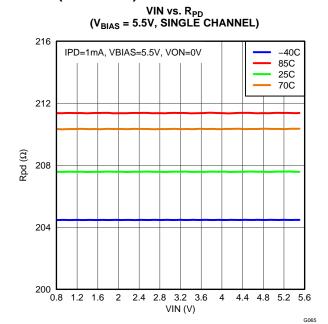


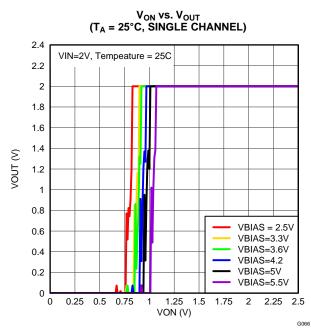
$V_{\rm IN}$ vs. $R_{\rm ON}$ ($V_{\rm BIAS}$ = 5.5V, SINGLE CHANNEL)

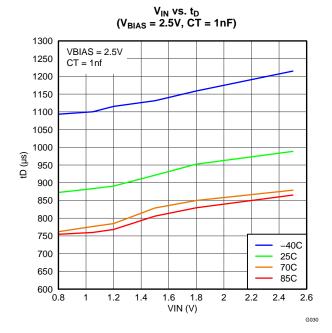




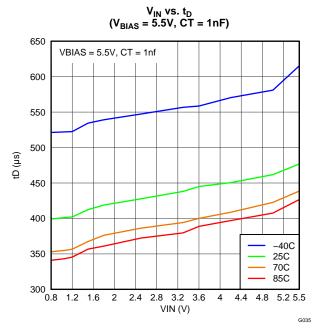


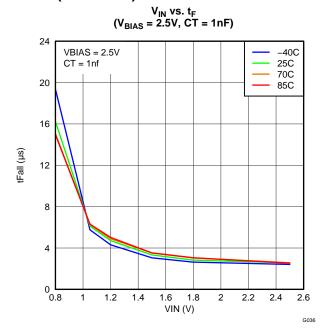


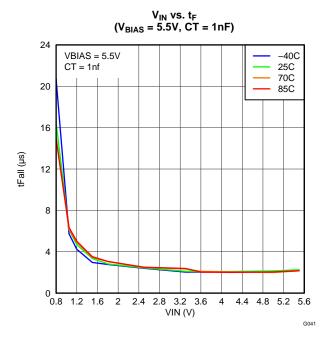


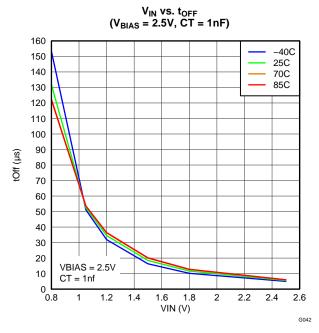




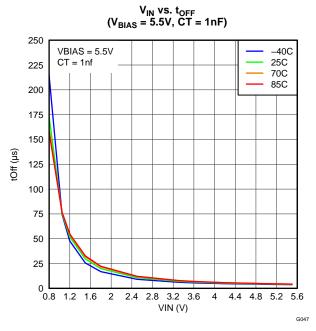


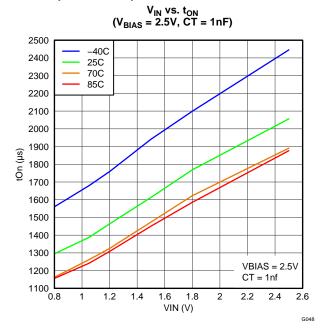


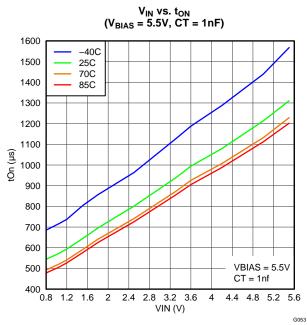


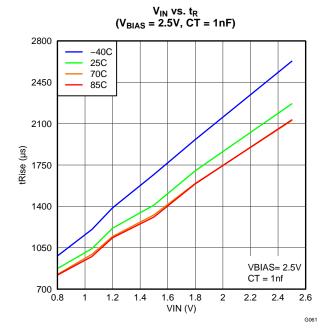




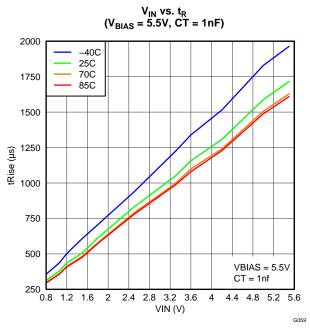


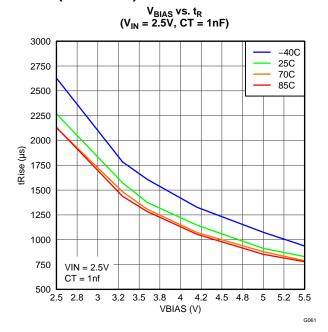












Value



TYPICAL AC SCOPE CAPTURES @ $T_A = 25^{\circ}C$, CT = 1nF

TURN-ON RESPONSE TIME

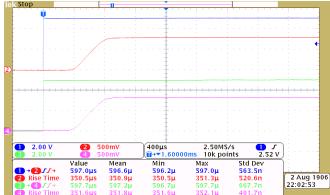
 $(V_{IN} = 0.8V, V_{BIAS} = 2.5V, C_{IN} = 1\mu F, C_L = 0.1\mu F, R_L = 10\Omega)$



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TURN-ON RESPONSE TIME

 $(V_{IN} = 0.8V, V_{BIAS} = 5.0V, C_{IN} = 1\mu F, C_L = 0.1\mu F, R_L = 10\Omega)$



TURN-ON RESPONSE TIME

Min 1.263m 844.4µ 1.294m

 $(V_{IN} = 2.5V, V_{BIAS} = 2.5V, C_{IN} = 1\mu F, C_L = 0.1\mu F, R_L = 10\Omega)$

2 50MS/s

10k points

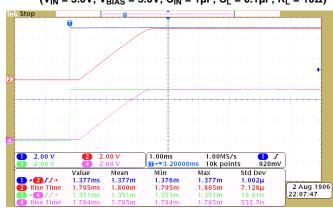
1) J 2.52 V

Std Dev



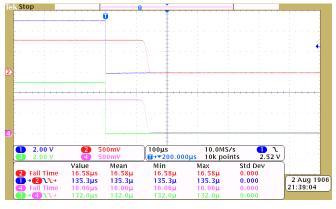
TURN-ON RESPONSE TIME

 $(V_{IN} = 5.0V, V_{BIAS} = 5.0V, C_{IN} = 1\mu F, C_L = 0.1\mu F, R_L = 10\Omega)$



TURN-OFF RESPONSE TIME

 $(V_{IN} = 0.8V, V_{BIAS} = 2.5V, C_{IN} = 1\mu F, C_L = 0.1\mu F, R_L = 10\Omega)$



TURN-OFF RESPONSE TIME

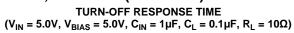
 $(V_{IN} = 0.8V, V_{BIAS} = 5.0V, C_{IN} = 1\mu F, C_L = 0.1\mu F, R_L = 10\Omega)$

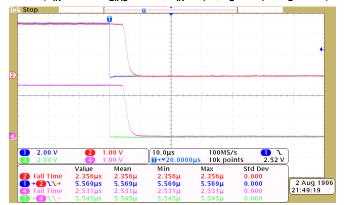


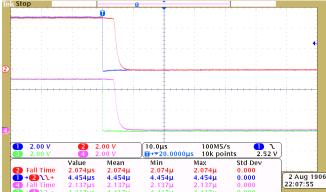


TYPICAL AC SCOPE CAPTURES @ $T_A = 25^{\circ}C$, CT = 1nF (continued)

TURN-OFF RESPONSE TIME (V_{IN} = 2.5V, V_{BIAS} = 2.5V, C_{IN} = 1 μ F, C_L = 0.1 μ F, R_L = 10 Ω)









APPLICATION INFORMATION

ON/OFF CONTROL

The ON pins control the state of the switch. Asserting ON high enables the switch. ON is active high and has a low threshold, making it capable of interfacing with low-voltage signals. The ON pin is compatible with standard GPIO logic threshold. It can be used with any microcontroller with 1.2-V or higher GPIO voltage. This pin cannot be left floating and must be tied either high or low for proper functionality.

INPUT CAPACITOR (OPTIONAL)

To limit the voltage drop on the input supply caused by transient in-rush currents when the switch turns on into a discharged load capacitor or short-circuit, a capacitor needs to be placed between V_{IN} and GND. A 1- μ F ceramic capacitor, C_{IN} , placed close to the pins, is usually sufficient. Higher values of C_{IN} can be used to further reduce the voltage drop during high-current application. When switching heavy loads, it is recommended to have an input capacitor about 10 times higher than the output capacitor to avoid excessive voltage drop.

OUTPUT CAPACITOR (OPTIONAL)

Due to the integrated body diode in the NMOS switch, a C_{IN} greater than C_L is highly recommended. A C_L greater than C_{IN} can cause V_{OUT} to exceed V_{IN} when the system supply is removed. This could result in current flow through the body diode from V_{OUT} to V_{IN} . A C_{IN} to C_L ratio of 10 to 1 is recommended for minimizing V_{IN} dip caused by inrush currents during startup.

V_{IN} and V_{BIAS} VOLTAGE RANGE

For optimal R_{ON} performance, make sure $V_{IN} \le V_{BIAS}$. The device will still be functional if $V_{IN} > V_{BIAS}$ but it will exhibit R_{ON} greater than what is listed in the ELECTRICAL CHARACTERISTICS table. See Figure 4 for an example of a typical device. Notice the increasing R_{ON} as V_{IN} exceeds V_{BIAS} voltage. Be sure to never exceed the maximum voltage rating for V_{IN} and V_{BIAS} .

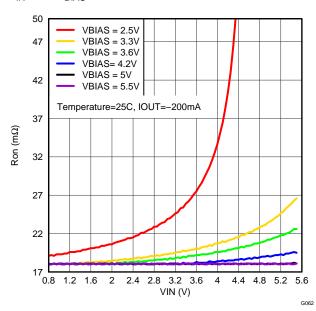


Figure 4. R_{ON} vs. V_{IN} ($V_{IN} > V_{BIAS}$, Single Channel)



ADJUSTABLE RISE TIME

A capacitor to GND on the CT pins sets the slew rate for each channel. An approximate formula for the relationship between CT and slew rate is (the equation below accounts for 10% to 90% measurement on V_{OUT} and does **NOT** apply for CT = 0pF. Use table below to determine rise times for when CT = 0pF):

$$SR = 0.32 \times CT + 13.7$$
 (1)

Where,

 $SR = slew rate (in \mu s/V)$

CT = the capacitance value on the CT pin (in pF)

The units for the constant 13.7 is in μ s/V.

Rise time can be calculated by multiplying the input voltage by the slew rate. The table below contains rise time values measured on a typical device. Rise times shown below are only valid for the power-up sequence where V_{IN} and V_{BIAS} are already in steady state condition, and the ON pin is asserted high.

CTx (pF)	RISE TIME (μ s) 10% - 90%, C_L = 0.1 μ F, C_{IN} = 1 μ F, R_L = 10 Ω TYPICAL VALUES at 25°C, 25V X7R 10% CERAMIC CAP							
	5V	3.3V	1.8V	1.5V	1.2V	1.05V	V8.0	
0	124	88	63	60	53	49	42	
220	481	323	193	166	143	133	109	
470	855	603	348	299	251	228	175	
1000	1724	1185	670	570	469	411	342	
2200	3328	2240	1308	1088	893	808	650	
4700	7459	4950	2820	2429	1920	1748	1411	
10000	16059	10835	6040	5055	4230	3770	3033	

Product Folder Link(s): TPS22966



BOARD LAYOUT AND THERMAL CONSIDERATIONS

For best performance, all traces should be as short as possible. To be most effective, the input and output capacitors should be placed close to the device to minimize the effects that parasitic trace inductances may have on normal operation. Using wide traces for V_{IN} , V_{OUT} , and GND helps minimize the parasitic electrical effects along with minimizing the case to ambient thermal impedance.

The maximum IC junction temperature should be restricted to 125°C under normal operating conditions. To calculate the maximum allowable dissipation, $P_{D(max)}$ for a given output current and ambient temperature, use the following equation:

$$\mathsf{P}_{\mathsf{D}(\mathsf{max})} = \frac{\mathsf{T}_{\mathsf{J}(\mathsf{max})} - \mathsf{T}_{\mathsf{A}}}{\Theta_{\mathsf{JA}}} \tag{2}$$

Where:

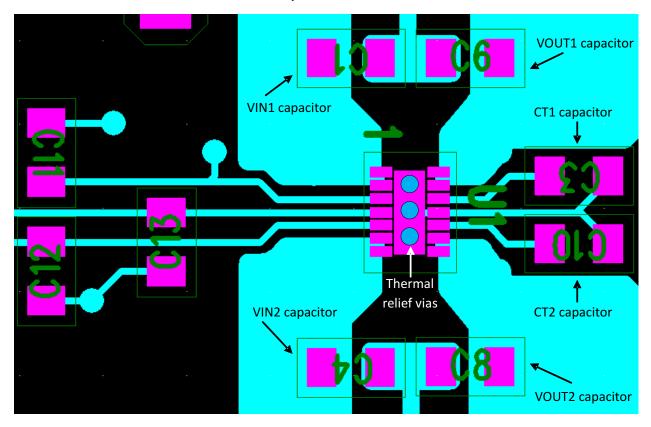
 $P_{D(max)}$ = maximum allowable power dissipation

 $T_{J(max)}$ = maximum allowable junction temperature (125°C for the TPS22966)

 T_A = ambient temperature of the device

 Θ_{JA} = junction to air thermal impedance. See Thermal Information section. This parameter is highly dependent upon board layout.

The figure below shows an example of a layout. Notice the thermal vias located under the exposed thermal pad of the device. This allows for thermal diffusion away from the device.





REVISION HISTORY

CI	Page	
•	Updated V _{BIAS} vs. QUIESCENT CURRENT (BOTH CHANNELS) Y-axis Units.	8
•	Updated V _{BIAS} vs. QUIESCENT CURRENT (SINGLE CHANNEL) Y-axis Units	8

Product Folder Link(s): TPS22966





9-.lul-2012

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
TPS22966DPUR	ACTIVE	WSON	DPU	14	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
TPS22966DPUT	ACTIVE	WSON	DPU	14	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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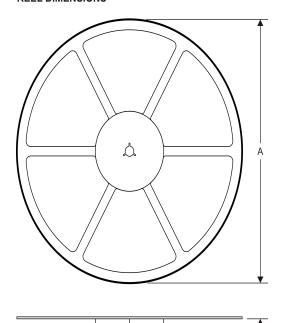
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PACKAGE MATERIALS INFORMATION

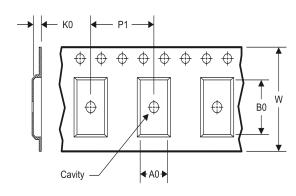
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TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



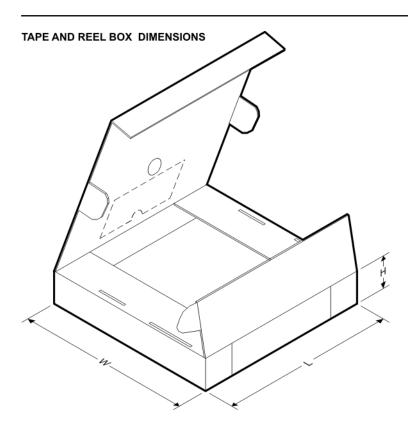
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

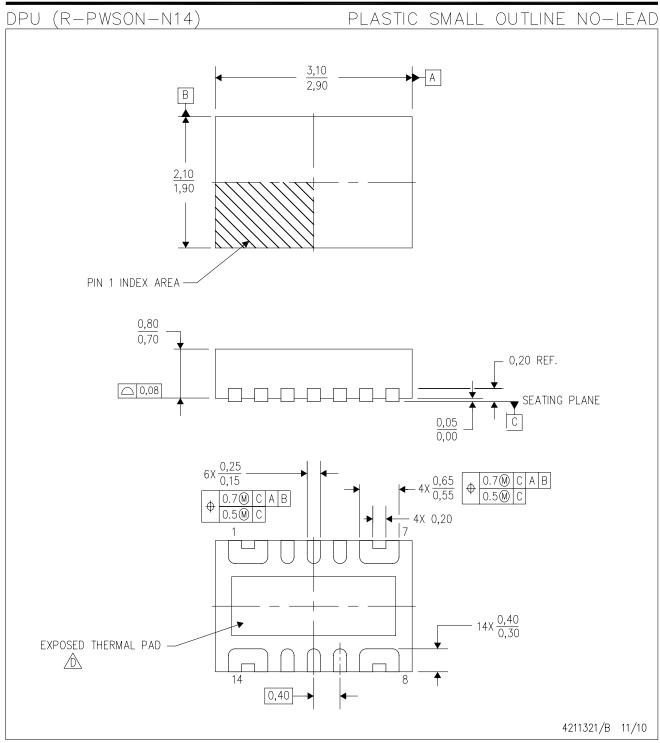
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS22966DPUR	WSON	DPU	14	3000	180.0	8.4	2.25	3.25	1.05	4.0	8.0	Q1
TPS22966DPUT	WSON	DPU	14	250	180.0	8.4	2.25	3.25	1.05	4.0	8.0	Q1

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS22966DPUR	WSON	DPU	14	3000	210.0	185.0	35.0
TPS22966DPUT	WSON	DPU	14	250	210.0	185.0	35.0



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.

- B. This drawing is subject to change without notice.
- Ç. Small Outline No-Lead (SON) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance.

 See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
- E. This package is Pb-free.



DPU (R-PWSON-N14)

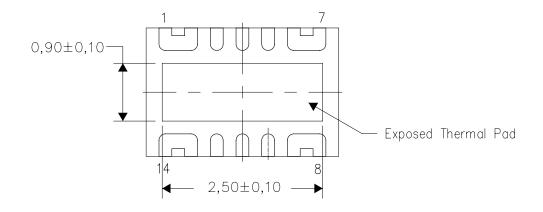
PLASTIC SMALL OUTLINE NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

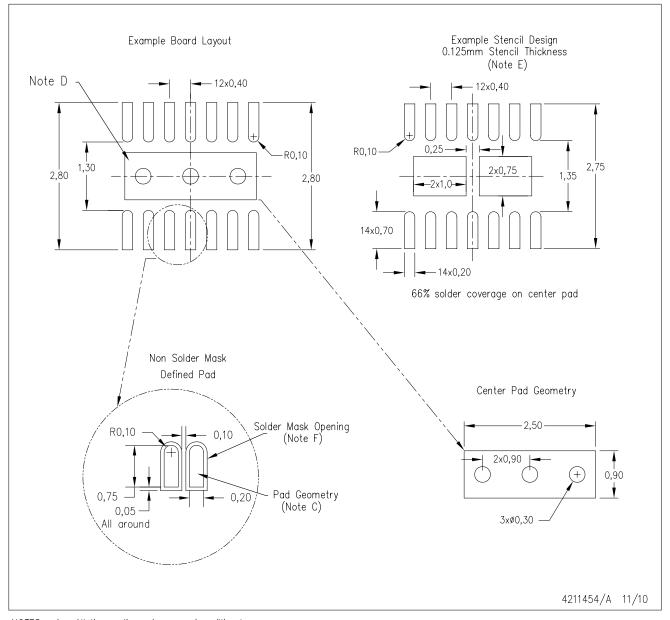
4211395/A 10/10

NOTE: A. All linear dimensions are in millimeters



DPU (R-PWSON-N14)

PLASTIC SMALL OUTLINE NO-LEAD



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



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